

Notice of References Cited

Application/Control No.

09/457,267

Applicant(s)/Patent Under
Reexamination
IWAYAMA, NAOMI

Examiner

Charles A. Bieneman

Art Unit

2176

Page 1 of 1


U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,005,498	12-1999	Yang et al.	341/23
	B	US-5,829,023	10-1998	Bishop, Peter B.	711/118
	C	US-6,507,891 B1	01-2003	Challenger et al.	711/122
	D	US-6,453,404 B1	09-2002	Bereznyi et al.	711/171
	E	US-6,307,541 B1	10-2001	Ho et al.	345/171
	F	US-6,204,848 B1	03-2001	Nowlan et al.	345/810
	G	US-6,170,000 B1	01-2001	Bories et al.	715/535
	H	US-6,112,215	08-2000	Kaply, Michael Aaron	715/507
	I	US-5,818,437	10-1998	Grover et al.	345/811
	J	US-5,404,299	04-1995	Tsurubayashi et al.	704/10
	K	US-5,387,042	02-1995	Brown, Carl W.	400/477
	L	US-5,128,672	07-1992	Kaehler, Edwin B.	341/23
	M	US-2002/0188942 A1	12-2002	BRYAN et al.	717/176

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.